

Notice of References Cited	Application/Control No. 09/002,906	Applicant(s)/Patent Under Reexamination WUGOFSKI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
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	B	US-5734589-	03-1998	Kostreski et al.	725	117
	C	US-6249320-	06-2001	Schneidewend et al.	725	56
	D	US-5600378-	02-1997	Wasilewski	348	468
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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